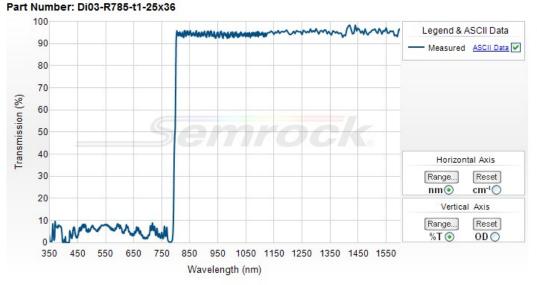
785 nm laser BrightLine® single-edge super-resolution laser dichroic beamsplitter





Semrock, Inc.

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(within US and Canada)

Your filter spectrum may differ slightly from the typical spectrum above, but is certified to meet the optical specifications noted below.



785 nm laser BrightLine® single-edge super-resolution laser dichroic beamsplitter

The perfect beamsplitters for the most popular lasers used in fluorescence imaging, including all-solid-state lasers. All beamsplitters in this category have exceptional reflectance at the laser wavelengths, wider reflection bands — into UV for photoactivation and super-resolution techniques, and extended transmission regions — into IR to 1200 or 1600 nm, and anti-reflection (AR) coatings to minimize imaging artifacts resulting from the coherent laser light.

Semrock's super-resolution laser dichroics deliver industry-leading flatness for minimal focus shift and optical wavefront aberrations of the laser beam spot to enable popular imaging and Super-resolution techniques such as TIRF, PALM, STORM, Structured-Illumination, and STED.

1λ P-V RWE on 1 mm λ/5 P-V RWE on 3 mm

Part Number	Size	Price1	Stock Status
Di03-R785-t1-25x36	25.2 mm x 35.6 mm x 1.1 mm (unmounted)	\$545	2 nd Day Ship
Di03-R785-t3-25x36	25.2 mm x 35.6 mm x 3.0 mm (unmounted)	\$645	2nd Day Ship

This part is not available for custom sizing - contact us (semrock@idexcorp.com) for 50.8mm sizes

1) US domestic pricing only. If you are ordering from outside the US, please contact your nearest regional distributor for the correct list price.

Optical Specifications

Specification	Value	
Reflection Band 1	Rabs > 94% 780 – 790 nm	
Reflection Band 1 (p-pol)	Rabs > 90% 780 – 790 nm	
Reflection Band 1 (s-pol)	Rabs > 98% 780 – 790 nm	
Reflection Band 2	Ravg > 90% 350 - 780 nm	
Edge Wavelength 1	800 nm	
Transmission Band 1	Tavg > 93% 804.3 – 1600 nm	
Laser Wavelengths 1	780 nm, 785 nm, 790nm	

General Filter Specifications

Specification	Value	
Angle of Incidence	45 degrees with a shift of 0.35%/degree (40 – 50 degrees)	
Cone Half-angle	0.5 degrees	
Optical Damage Rating	1 J/cm² @ 532 nm (10 ns pulse width)	
Flatness (1 mm thickness)	1λ P-V RWE @ 632.8 nm	
Flatness (3 mm thickness)	λ/5 P-V RWE @ 632.8 nm	
Steepness	Steep	
Effective Index	2.04	

Physical Filter Specifications (applies to standard sized parts; contact us regarding other sizes)

Specification	Value
Transverse Dimensions (L x W)	25.2 mm x 35.6 mm
Transverse Tolerance	± 0.1 mm
Filter Thickness (1 mm, unmounted)	1.05 mm
Filter Thickness Tolerance (1 mm, unmounted)	± 0.05 mm
Filter Thickness (3 mm, unmounted)	3.0 mm
Filter Thickness Tolerance (3 mm, unmounted)	± 0.1 mm
Clear Aperture	≥ 80% (elliptical)
Scratch-Dig	60-40
Substrate Type	Fused Silica
Substrate Thickness (1 mm, unmounted)	1.05 mm
Substrate Thickness Tolerance (1 mm, unmounted)	± 0.05 mm
Substrate Thickness (3 mm, unmounted)	3.0 mm
Substrate Thickness Tolerance (3 mm, unmounted)	± 0.1 mm
Orientation	Reflective surface marked with laser dot - Orient in direction of incoming light